Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/052,692	LIN-HENDEL, CATHERINE
Examiner	Art Unit
X. L. Bautista	2179

SEARCHED					
Class	Subclass	Date	Examiner		
715	784-786	9/7/2007	ХВ		
	854,856				
	833				
	862				
715	501.1				
	512				
709	217				
			-		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
715	784-786	9/7/2007	ХВ		
	833,854				
	501.1	<del>-</del>			
709/217					

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST Search	9/7/2007	ХВ		
Databases searched: US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB				
Interference Search History				
Google Search				